

**16 Gb, 4-Bit ECC, ×8 I/O, and 1.8 V V<sub>CC</sub>  
NAND Flash for Embedded****Distinctive Characteristics**

- Density
  - 16 Gb (4 Gb × 4)
- Architecture (For each 4 Gb device)
  - Input / Output Bus Width: 8-bits
  - Page Size: (2048 + 128) bytes; 128-byte spare area
  - Block Size: 64 Pages or (128k + 8k) bytes
  - Plane Size
    - 2048 Blocks per Plane or (256M + 16M) bytes
  - Device Size
    - 2 Planes per Device or 512 Mbyte
- NAND Flash Interface
  - Open NAND Flash Interface (ONFI) 1.0 compliant
  - Address, Data and Commands multiplexed
- Supply Voltage
  - 1.8V device: V<sub>CC</sub> = 1.7V ~ 1.95V
- Security
  - One Time Programmable (OTP) area
  - Serial number (unique ID)
  - Hardware program/erase disabled during power transition
- Additional Features
  - Supports Multiplane Program and Erase commands
  - Supports Copy Back Program
  - Supports Multiplane Copy Back Program
  - Supports Read Cache
- Electronic Signature
  - Manufacturer ID: 01h
- Operating Temperature
  - Industrial: –40°C to 85°C

**Performance**

- Page Read / Program
  - Random access: 30 μs (Max)
  - Sequential access: 45 ns (Min)
  - Program time / Multiplane Program time: 300 μs (Typ)
- Block Erase / Multiplane Erase
  - Block Erase time: 3.5 ms (Typ)
- Reliability
  - 100,000 Program / Erase cycles (Typ) (with 4-bit ECC per 528 bytes)
  - 10 Year Data retention (Typ)
  - Blocks zero and one are valid and will be valid for at least 1000 program-erase cycles with ECC
- Package Options
  - Lead Free and Low Halogen
  - 63-Ball BGA 9 × 11 × 1.2 mm

## Contents

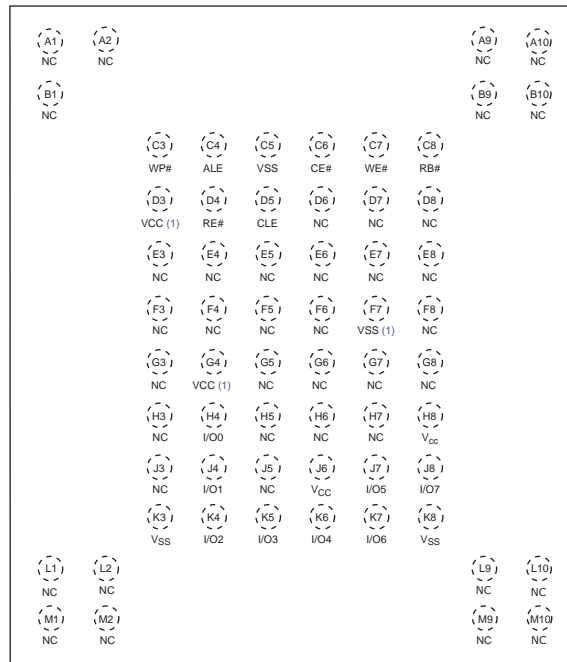
<b>Distinctive Characteristics</b> .....	1	8.3 Pin Capacitance.....	13
<b>Performance</b> .....	1	8.4 Power Consumptions and Pin Capacitance for Allowed Stacking Configurations.....	13
<b>1. General Description</b> .....	3	<b>9. Physical Interface</b> .....	14
<b>2. Connection Diagram</b> .....	3	9.1 63-Ball BGA Package .....	14
<b>3. Pin Description</b> .....	4	<b>10. Ordering Information</b> .....	15
<b>4. Block Diagrams</b> .....	5	<b>11. Revision History</b> .....	16
<b>5. Addressing</b> .....	7	<b>Document History Page</b> .....	<b>16</b>
<b>6. Read Status Enhanced</b> .....	7	<b>Sales, Solutions, and Legal Information</b> .....	<b>17</b>
<b>7. Read ID</b> .....	7	Worldwide Sales and Design Support .....	17
7.1 Read Parameter Page .....	9	Products .....	17
<b>8. Electrical Characteristics</b> .....	12	PSoC® Solutions .....	17
8.1 Valid Blocks .....	12	Cypress Developer Community .....	17
8.2 DC Characteristics.....	12	Technical Support .....	17

## 1. General Description

The Cypress® S34MS16G2 16-Gb NAND is offered in 1.8V V<sub>CC</sub> with x8 I/O interface. This document contains information for the S34MS16G2 device, which is a quad-die stack of four S34MS04G2 die. For detailed specifications, please refer to the discrete die data sheet: [S34MS01G2\\_04G2](#).

## 2. Connection Diagram

**Figure 2.1** 63-BGA Contact, x8 Device (Balls Down, Top View)



### 3. Pin Description

**Table 3.1** Pin Description

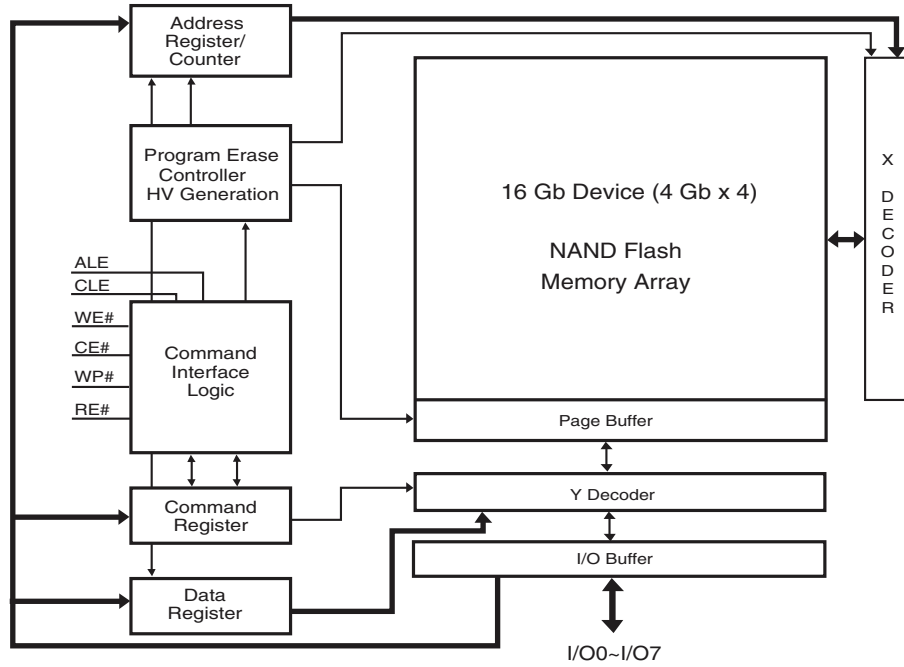
Pin Name	Description
I/O0 - I/O7	<b>Inputs/Outputs.</b> The I/O pins are used for command input, address input, data input, and data output. The I/O pins float to High-Z when the device is deselected or the outputs are disabled.
CLE	<b>Command Latch Enable.</b> This input activates the latching of the I/O inputs inside the Command Register on the rising edge of Write Enable (WE#).
ALE	<b>Address Latch Enable.</b> This input activates the latching of the I/O inputs inside the Address Register on the rising edge of Write Enable (WE#).
CE#	<b>Chip Enable.</b> This input controls the selection of the device. When the device is not busy CE# low selects the memory.
WE#	<b>Write Enable.</b> This input latches Command, Address and Data. The I/O inputs are latched on the rising edge of WE#.
RE#	<b>Read Enable.</b> The RE# input is the serial data-out control, and when active drives the data onto the I/O bus. Data is valid $t_{REA}$ after the falling edge of RE# which also increments the internal column address counter by one.
WP#	<b>Write Protect.</b> The WP# pin, when low, provides hardware protection against undesired data modification (program / erase).
R/B#	<b>Ready Busy.</b> The Ready/Busy output is an Open Drain pin that signals the state of the memory.
V <sub>CC</sub>	<b>Supply Voltage.</b> The V <sub>CC</sub> supplies the power for all the operations (Read, Program, Erase). An internal lock circuit prevents the insertion of Commands when V <sub>CC</sub> is less than V <sub>LKO</sub> .
V <sub>SS</sub>	<b>Ground.</b>
NC	<b>Not Connected.</b>

**Notes:**

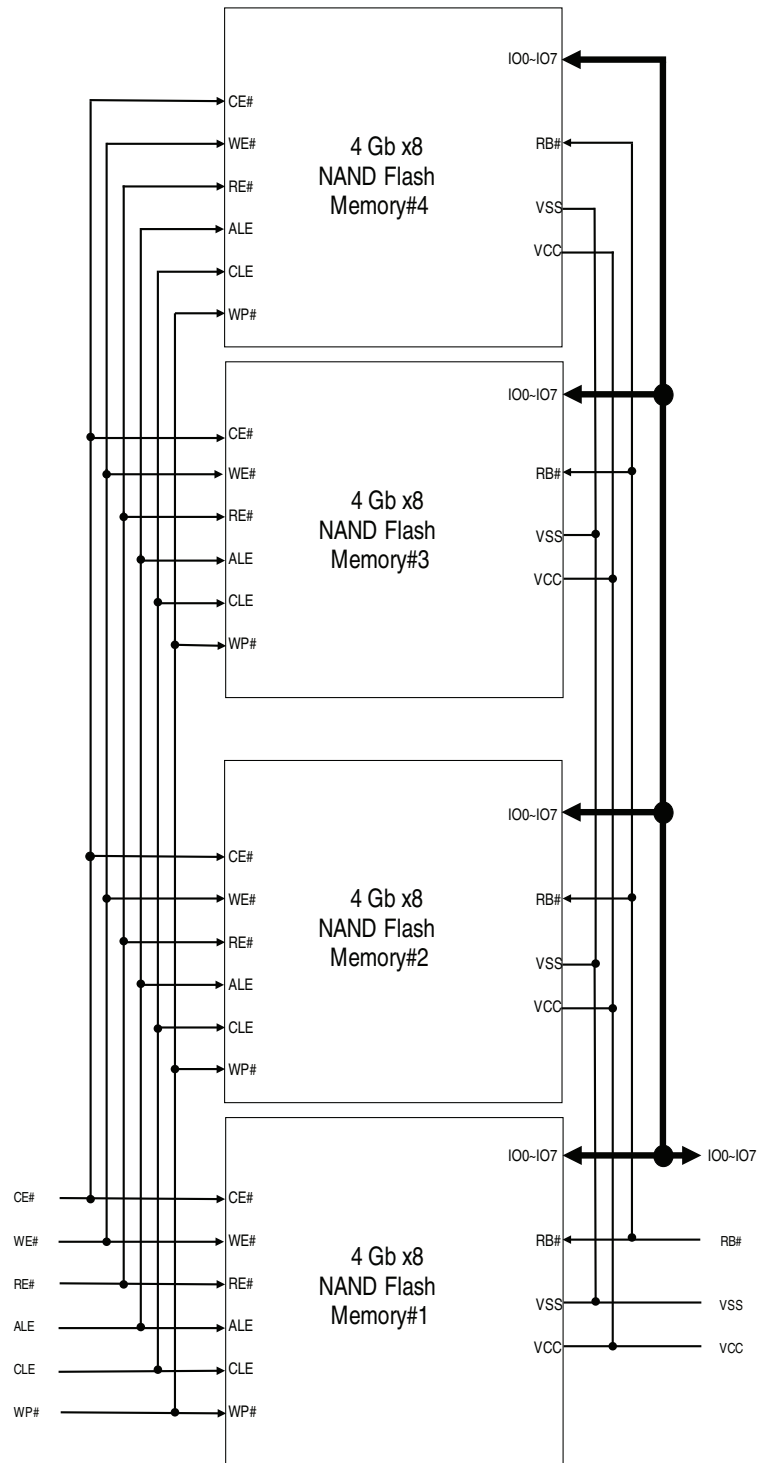
1. A 0.1  $\mu$ F capacitor should be connected between the V<sub>CC</sub> Supply Voltage pin and the V<sub>SS</sub> Ground pin to decouple the current surges from the power supply. The PCB track widths must be sufficient to carry the currents required during program and erase operations.
2. An internal voltage detector disables all functions whenever V<sub>CC</sub> is below 1.8V to protect the device from any involuntary program/erase during power transitions.

## 4. Block Diagrams

**Figure 4.1** Functional Block Diagram



**Figure 4.2** Block Diagram — 16 Gb (4 Gb x 4) 63-Ball BGA with 1 CE# (One Chip Enable Signal)



## 5. Addressing

**Table 5.1** Address Cycle Map

Bus Cycle	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
1st / Col. Add. 1	A0 (CA0)	A1 (CA1)	A2 (CA2)	A3 (CA3)	A4 (CA4)	A5 (CA5)	A6 (CA6)	A7 (CA7)
2nd / Col. Add. 2	A8 (CA8)	A9 (CA9)	A10 (CA10)	A11 (CA11)	Low	Low	Low	Low
3rd / Row Add. 1	A12 (PA0)	A13 (PA1)	A14 (PA2)	A15 (PA3)	A16 (PA4)	A17 (PA5)	A18 (PLA0)	A19 (BA0)
4th / Row Add. 2	A20 (BA1)	A21 (BA2)	A22 (BA3)	A23 (BA4)	A24 (BA5)	A25 (BA6)	A26 (BA7)	A27 (BA8)
5th / Row Add. 3 (6)	A28 (BA9)	A29 (BA10)	A30 (BA11)	A31 (BA12)	Low	Low	Low	Low

**Notes:**

1. CAx = Column Address bit.
2. PAx = Page Address bit.
3. PLA0 = Plane Address bit zero.
4. BAx = Block Address bit.
5. Block address concatenated with page address and plane address = actual page address, also known as the row address.
6. A31 for 16 Gb (4 Gb x 4 – QDP).

For the address bits, the following rules apply:

- A0–A11: column address in the page
- A12–A17: page address in the block
- A18: plane address (for multiplane operations) / block address (for normal operations)
- A19–A31: block address

## 6. Read Status Enhanced

Read Status Enhanced is used to retrieve the status value for a previous operation in the following cases:

- In the case of concurrent operations on a multi-die stack.

When four dies are stacked to form a quad-die package (QDP), it is possible to run one operation on the first die, then activate a different operation on the second die, for example: Erase while Read, Read while Program, etc.

- In the case of multiplane operations in the same die.

## 7. Read ID

The device contains a product identification mode, initiated by writing 90h to the command register, followed by an address input of 00h.

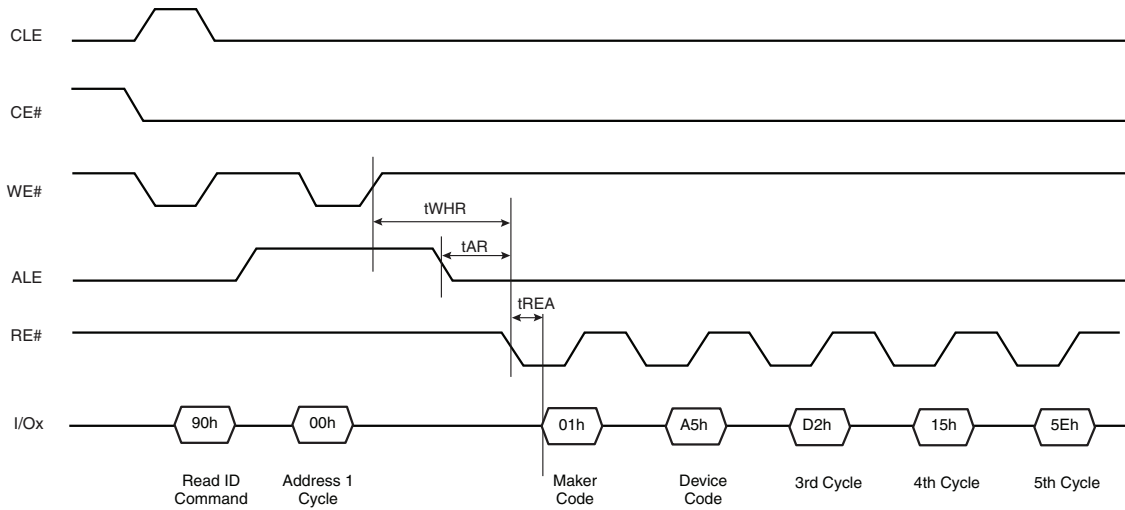
**Note:** If you want to execute Read Status command (0x70) after Read ID sequence, you should input dummy command (0x00) before Read Status command (0x70).

For the S34MS16G2 device, five read cycles sequentially output the manufacturer code (01h), and the device code and 3rd, 4th, and 5th cycle ID, respectively. The command register remains in Read ID mode until further commands are issued to it.

**Table 7.1** Read ID for Supported Configurations

Density	Org	V <sub>CC</sub>	1st	2nd	3rd	4th	5th
4 Gb	x8	1.8V	01h	ACh	90h	15h	56h
16 Gb (4 Gb x 4 – QDP with one CE#)	x8	1.8V	01h	A5h	D2h	15h	5Eh

Figure 7.1 Read ID Operation Timing



5<sup>th</sup> ID Data

Table 7.2 Read ID Byte 5 Description

	Description	I/O7	I/O6 I/O5 I/O4	I/O3 I/O2	I/O1 I/O0
ECC Level	1 bit / 512 bytes				0 0
	2 bit / 512 bytes				0 1
	4 bit / 512 bytes				1 0
	8 bit / 512 bytes				1 1
Plane Number	1			0 0	
	2			0 1	
	4			1 0	
	8			1 1	
Plane Size (without spare area)	64 Mb		0 0 0		
	128 Mb		0 0 1		
	256 Mb		0 1 0		
	512 Mb		0 1 1		
	1 Gb		1 0 0		
	2 Gb		1 0 1		
	4 Gb		1 1 0		
Reserved		0			



## 7.1 Read Parameter Page

The device supports the ONFI Read Parameter Page operation, initiated by writing ECh to the command register, followed by an address input of 00h. The command register remains in Parameter Page mode until further commands are issued to it. [Table 7.3](#) explains the parameter fields.

**Note:** For 32nm Cypress NAND, for a particular condition, the Read Parameter Page command does not give the correct values. To overcome this issue, the host must issue a Reset command before the Read Parameter Page command. Issuance of Reset before the Read Parameter Page command will provide the correct values and will not output 00h values.

**Table 7.3** Parameter Page Description

Byte	O/M	Description	Values
<b>Revision Information and Features Block</b>			
0-3	M	Parameter page signature Byte 0: 4Fh, "O" Byte 1: 4Eh, "N" Byte 2: 46h, "F" Byte 3: 49h, "I"	4Fh, 4Eh, 46h, 49h
4-5	M	Revision number 2-15 Reserved (0) 1 1 = supports ONFI version 1.0 0 Reserved (0)	02h, 00h
6-7	M	Features supported 5-15 Reserved (0) 4 1 = supports odd to even page Copyback 3 1 = supports interleaved operations 2 1 = supports non-sequential page programming 1 1 = supports multiple LUN operations 0 1 = supports 16-bit data bus width	1Eh, 00h
8-9	M	Optional commands supported 6-15 Reserved (0) 5 1 = supports Read Unique ID 4 1 = supports Copyback 3 1 = supports Read Status Enhanced 2 1 = supports Get Features and Set Features 1 1 = supports Read Cache commands 0 1 = supports Page Cache Program command	3Bh, 00h
10-31		Reserved (0)	00h
<b>Manufacturer Information Block</b>			
32-43	M	Device manufacturer (12 ASCII characters)	53h, 50h, 41h, 4Eh, 53h, 49h, 4Fh, 4Eh, 20h, 20h, 20h, 20h
44-63	M	Device model (20 ASCII characters)	53h, 33h, 34h, 4Dh, 53h, 31h, 36h, 47h, 32h, 20h, 20h, 20h, 20h, 20h, 20h, 20h, 20h, 20h, 20h
64	M	JEDEC manufacturer ID	01h
65-66	O	Date code	00h
67-79		Reserved (0)	00h
<b>Memory Organization Block</b>			
80-83	M	Number of data bytes per page	00h, 08h, 00h, 00h
84-85	M	Number of spare bytes per page	80h, 00h
86-89	M	Number of data bytes per partial page	00h, 00h, 00h, 00h
90-91	M	Number of spare bytes per partial page	00h, 00h

**Table 7.3** Parameter Page Description (Continued)

Byte	O/M	Description	Values
92-95	M	Number of pages per block	40h, 00h, 00h, 00h
96-99	M	Number of blocks per logical unit (LUN)	00h, 40h, 00h, 00h (1 CE#)
100	M	Number of logical units (LUNs)	01h (1 CE#)
101	M	Number of address cycles 4-7 Column address cycles 0-3 Row address cycles	23h
102	M	Number of bits per cell	01h
103-104	M	Bad blocks maximum per LUN	47h, 01h (1 CE#)
105-106	M	Block endurance	01h, 05h
107	M	Guaranteed valid blocks at beginning of target	01h
108-109	M	Block endurance for guaranteed valid blocks	01h, 03h
110	M	Number of programs per page	04h
111	M	Partial programming attributes 5-7 Reserved 4 1 = partial page layout is partial page data followed by partial page spare 1-3 Reserved 0 1 = partial page programming has constraints	00h
112	M	Number of bits ECC correctability	04h
113	M	Number of interleaved address bits 4-7 Reserved (0) 0-3 Number of interleaved address bits	01h
114	O	Interleaved operation attributes 4-7 Reserved (0) 3 Address restrictions for program cache 2 1 = program cache supported 1 1 = no block address restrictions 0 Overlapped / concurrent interleaving support	04h
115-127		Reserved (0)	00h
<b>Electrical Parameters Block</b>			
128	M	I/O pin capacitance	0Ah
129-130	M	Timing mode support 6-15 Reserved (0) 5 1 = supports timing mode 5 4 1 = supports timing mode 4 3 1 = supports timing mode 3 2 1 = supports timing mode 2 1 1 = supports timing mode 1 0 1 = supports timing mode 0, shall be 1	03h, 00h
131-132	O	Program cache timing mode support 6-15 Reserved (0) 5 1 = supports timing mode 5 4 1 = supports timing mode 4 3 1 = supports timing mode 3 2 1 = supports timing mode 2 1 1 = supports timing mode 1 0 1 = supports timing mode 0	03h, 00h
133-134	M	t <sub>PROG</sub> Maximum page program time (μs)	BCh, 02h

**Table 7.3** Parameter Page Description (Continued)

Byte	O/M	Description	Values
135-136	M	t <sub>BERS</sub> Maximum block erase time (μs)	10h, 27h
137-138	M	t <sub>R</sub> Maximum page read time (μs)	1Eh, 00h
139-140	M	t <sub>CCS</sub> Minimum Change Column setup time (ns)	C8h, 00h
141-163		Reserved (0)	00h
<b>Vendor Block</b>			
164-165	M	Vendor specific Revision number	00h
166-253		Vendor specific	00h
254-255	M	Integrity CRC	11h, F5h (1CE#)
<b>Redundant Parameter Pages</b>			
256-511	M	Value of bytes 0-255	Repeat Value of bytes 0-255
512-767	M	Value of bytes 0-255	Repeat Value of bytes 0-255
768+	O	Additional redundant parameter pages	FFh

**Note:**

1. "O" Stands for Optional, "M" for Mandatory.

## 8. Electrical Characteristics

### 8.1 Valid Blocks

**Table 8.1** Valid Blocks

Device	Symbol	Min	Typ	Max	Unit
S34MS04G2	N <sub>VB</sub>	4016	—	4096	Blocks
S34MS16G2	N <sub>VB</sub>	16057 (1)	—	16384	Blocks

**Note:**

- Each 4 Gb can have a maximum 80 bad blocks.

### 8.2 DC Characteristics

**Table 8.2** DC Characteristics and Operating Conditions

(Values listed are for each 4 Gb NAND, 16 Gb (4 Gb x 4) will differ accordingly)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Power On Current	I <sub>CC0</sub>	FFh command input after power on	—	—	50 per device	mA
Operating Current	Sequential Read	t <sub>RC</sub> = t <sub>RC</sub> (min) CE# = V <sub>IL</sub> , I <sub>out</sub> = 0 mA	—	15	30	mA
	Program	Normal	—	15	30	mA
		Cache	—	—	15	30
Erase	I <sub>CC3</sub>	—	—	15	30	mA
Standby Current, (TTL)	I <sub>CC4</sub>	CE# = V <sub>IH</sub> , WP# = 0V/V <sub>CC</sub>	—	—	1	mA
Standby Current, (CMOS)	I <sub>CC5</sub>	CE# = V <sub>CC</sub> -0.2, WP# = 0/V <sub>CC</sub>	—	10	50	μA
Input Leakage Current	I <sub>LI</sub>	V <sub>IN</sub> = 0 to V <sub>CC</sub> (max)	—	—	±10	μA
Output Leakage Current	I <sub>LO</sub>	V <sub>OUT</sub> = 0 to V <sub>CC</sub> (max)	—	—	±10	μA
Input High Voltage	V <sub>IH</sub>	—	V <sub>CC</sub> x 0.8	—	V <sub>CC</sub> + 0.3	V
Input Low Voltage	V <sub>IL</sub>	—	-0.3	—	V <sub>CC</sub> x 0.2	V
Output High Voltage	V <sub>OH</sub>	I <sub>OH</sub> = -100 μA	V <sub>CC</sub> -0.1	—	—	V
Output Low Voltage	V <sub>OL</sub>	I <sub>OL</sub> = 100 μA	—	—	0.1	V
Output Low Current (R/B#)	I <sub>OL(R/B#)</sub>	V <sub>OL</sub> = 0.1V	3	4	—	mA
Erase and Program Lockout Voltage	V <sub>LKO</sub>	—	—	1.1	—	V

**Notes:**

- All V<sub>CC</sub> pins, and V<sub>SS</sub> pins respectively, are shorted together.
- Values listed in this table refer to the complete voltage range for V<sub>CC</sub> and to a single device in case of device stacking.
- All current measurements are performed with a 0.1 μF capacitor connected between the V<sub>CC</sub> Supply Voltage pin and the V<sub>SS</sub> Ground pin.
- Standby current measurement can be performed after the device has completed the initialization process at power up.

### 8.3 Pin Capacitance

**Table 8.3** Pin Capacitance (TA = 25°C, f=1.0 MHz)

Parameter	Symbol	Test Condition	Min	Max	Unit
Input	$C_{IN}$	$V_{IN} = 0V$	—	10	pF
Input / Output	$C_{IO}$	$V_{IL} = 0V$	—	10	pF

**Note:**

1. For the stacked devices version the Input is 10 pF x [number of stacked chips] and the Input/Output is 10 pF x [number of stacked chips].

### 8.4 Power Consumptions and Pin Capacitance for Allowed Stacking Configurations

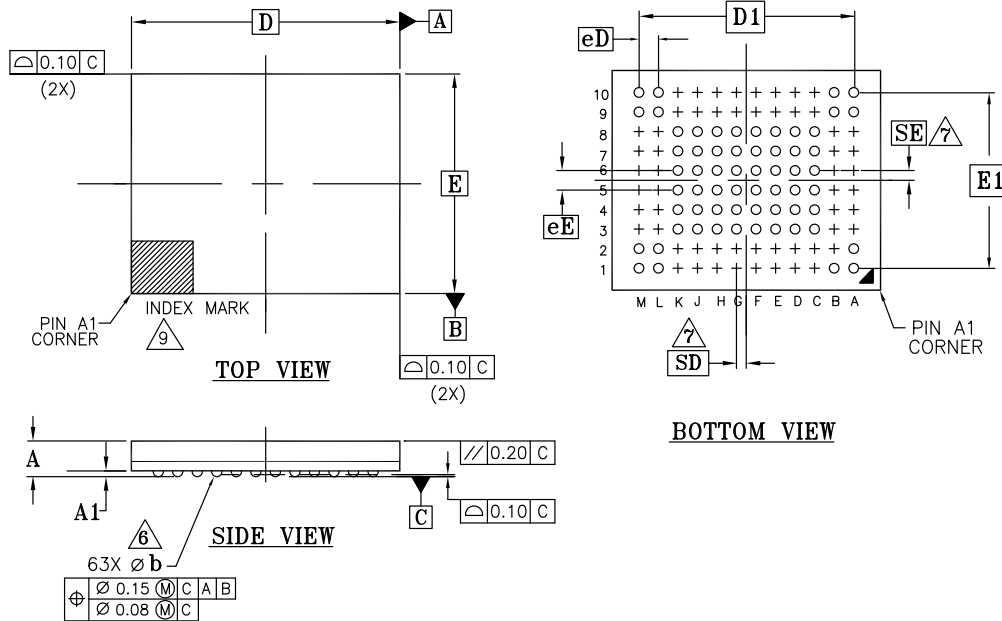
When multiple dies are stacked in the same package, the power consumption of the stack will increase according to the number of chips. As an example, the standby current is the sum of the standby currents of all the chips, while the active power consumption depends on the number of chips concurrently executing different operations.

When multiple dies are stacked in the same package the pin/ball capacitance for the single input and the single input/output of the combo package must be calculated based on the number of chips sharing that input or that pin/ball.

## 9. Physical Interface

### 9.1 63-Ball BGA Package

Figure 9.1 63-Ball BGA 9 x 11 x 1.2 mm



PACKAGE	TNA 063			NOTE
JEDEC	MO-207(N)			
D X E	11.00mm X 9.00mm PACKAGE			
SYMBOL	MIN.	NOM.	MAX.	
A	---	---	1.20	PROFILE
A1	0.25	---	---	BALL HEIGHT
D	11.00 BSC			BODY SIZE
E	9.00 BSC			BODY SIZE
D1	8.80 BSC			MATRIX FOOTPRINT
E1	7.20 BSC			MATRIX FOOTPRINT
MD	12			MATRIX SIZE D DIRECTION
ME	10			MATRIX SIZE E DIRECTION
n	63			BALL COUNT
Ø b	0.40	0.45	0.50	BALL DIAMETER
eE	0.80 BSC			BALL PITCH
eD	0.80 BSC			BALL PITCH
SD	0.40 BSC			SOLDER BALL PLACEMENT
SE	0.40 BSC			SOLDER BALL PLACEMENT
	A3-A8,B2-B8,C1,C2,C9,C10,D1,D2,D9,D10,E1,E2,E9,E10,F1,F2,F9,F10,G1,G2,G9,G10,H1,H2,H9,H10,J1,J2,J9,J10,K1,K2,K9,K10,L3-L8,M3-M8			DEPOPULATED SOLDER BALLS

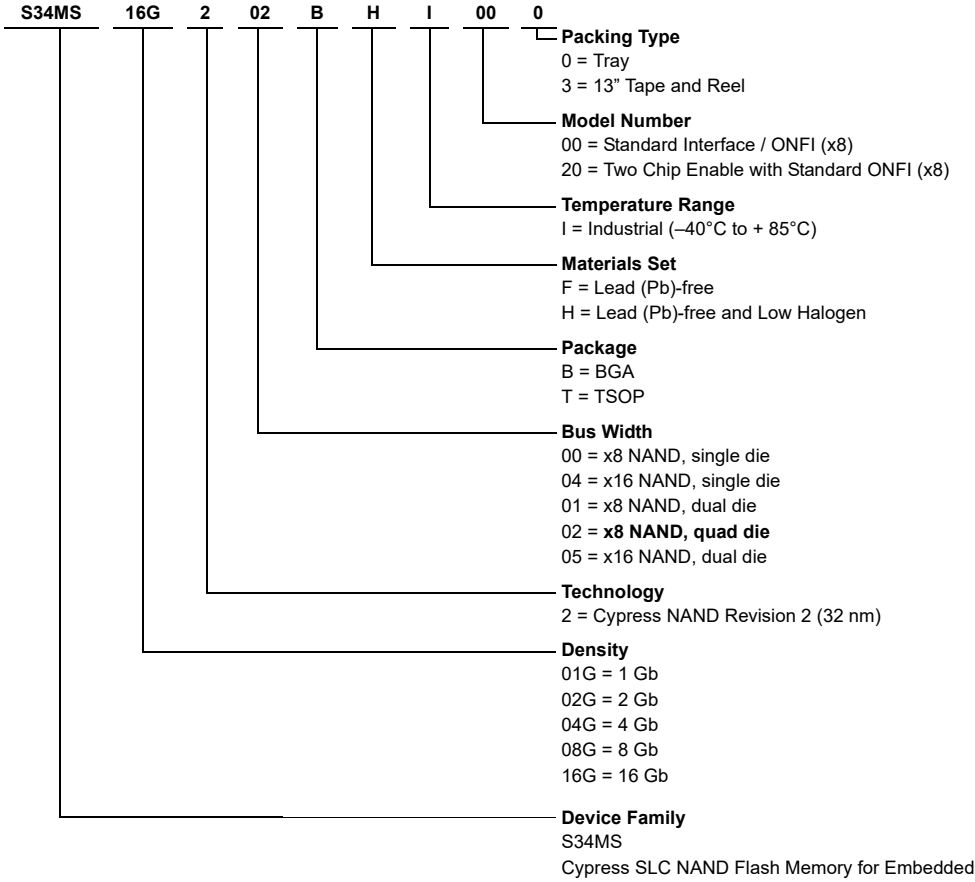
NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- ALL DIMENSIONS ARE IN MILLIMETERS.
- BALL POSITION DESIGNATION PER JEP 95, SECTION 3, SPP-020.
- [e] REPRESENTS THE SOLDER BALL GRID PITCH.
- SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION. SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION. n IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
- [6] DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.
- [7] "SD" AND "SE" ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW. WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW "SD" OR "SE" = 0. WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW "SD" = eD/2 AND "SE" = eE/2.
- "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.
- [9] A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

gs5038-tna063-09.05.14

## 10. Ordering Information

The ordering part number is formed by a valid combination of the following:



### Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult your local sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Valid Combinations								
Device Family	Density	Technology	Bus Width	Package Type	Temperature Range	Additional Ordering Options	Packing Type	Package Description
S34MS	16G	2	02	BH	I	BH – 00	0, 3	BGA

## 11. Revision History

### Document History Page

Document Title: S34MS16G2, 16 Gb, 4-Bit ECC, x8 I/O, and 1.8 V <sub>CC</sub> NAND Flash for Embedded				
Document Number: 002-00464				
Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change
**	–	XILA	12/12/2014	Initial release
*A	–	XILA	04/24/2015	Performance: Corrected Package Options for 63-Ball BGA to 9 x 11 x 1.2 mm Physical Interface: Corrected figure title to '63-Ball BGA 9 x 11 x 1.2 mm' Ordering Information: Ordering Information table: corrected Model Number and Materials Set
*B	4962771	XILA	10/14/2015	Updated to Cypress template.
*C	5244672	XILA	04/28/2016	Changed status from Advance to Final. Updated <a href="#">Read ID</a> : Updated <a href="#">Read Parameter Page</a> : Updated description. Updated to new template.
*D	5497766	XILA	10/27/2016	Updated <a href="#">Electrical Characteristics</a> : Updated <a href="#">DC Characteristics</a> : Updated <a href="#">Table 8.2</a> . Updated <a href="#">Notes 1 and 2</a> . Updated to new template.
*E	5962114	AESATMP8	11/09/2017	Updated logo and Copyright.
*F	6100827	MNAD	03/16/2018	Updated to new template. Completing Sunset Review.



## Sales, Solutions, and Legal Information

### Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at [Cypress Locations](#).

#### Products

Arm® Cortex® Microcontrollers	<a href="http://cypress.com/arm">cypress.com/arm</a>
Automotive	<a href="http://cypress.com/automotive">cypress.com/automotive</a>
Clocks & Buffers	<a href="http://cypress.com/clocks">cypress.com/clocks</a>
Interface	<a href="http://cypress.com/interface">cypress.com/interface</a>
Internet of Things	<a href="http://cypress.com/iot">cypress.com/iot</a>
Memory	<a href="http://cypress.com/memory">cypress.com/memory</a>
Microcontrollers	<a href="http://cypress.com/mcu">cypress.com/mcu</a>
PSoC	<a href="http://cypress.com/psoc">cypress.com/psoc</a>
Power Management ICs	<a href="http://cypress.com/pmic">cypress.com/pmic</a>
Touch Sensing	<a href="http://cypress.com/touch">cypress.com/touch</a>
USB Controllers	<a href="http://cypress.com/usb">cypress.com/usb</a>
Wireless Connectivity	<a href="http://cypress.com/wireless">cypress.com/wireless</a>

#### PSoC® Solutions

[PSoC 1](#) | [PSoC 3](#) | [PSoC 4](#) | [PSoC 5LP](#) | [PSoC 6 MCU](#)

#### Cypress Developer Community

[Community](#) | [Projects](#) | [Video](#) | [Blogs](#) | [Training](#) | [Components](#)

#### Technical Support

[cypress.com/support](http://cypress.com/support)

© Cypress Semiconductor Corporation, 2014-2018. This document is the property of Cypress Semiconductor Corporation and its subsidiaries, including Spansion LLC ("Cypress"). This document, including any software or firmware included or referenced in this document ("Software"), is owned by Cypress under the intellectual property laws and treaties of the United States and other countries worldwide. Cypress reserves all rights under such laws and treaties and does not, except as specifically stated in this paragraph, grant any license under its patents, copyrights, trademarks, or other intellectual property rights. If the Software is not accompanied by a license agreement and you do not otherwise have a written agreement with Cypress governing the use of the Software, then Cypress hereby grants you a personal, non-exclusive, nontransferable license (without the right to sublicense) (1) under its copyright rights in the Software (a) for Software provided in source code form, to modify and reproduce the Software solely for use with Cypress hardware products, only internally within your organization, and (b) to distribute the Software in binary code form externally to end users (either directly or indirectly through resellers and distributors), solely for use on Cypress hardware product units, and (2) under those claims of Cypress's patents that are infringed by the Software (as provided by Cypress, unmodified) to make, use, distribute, and import the Software solely for use with Cypress hardware products. Any other use, reproduction, modification, translation, or compilation of the Software is prohibited.

TO THE EXTENT PERMITTED BY APPLICABLE LAW, CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS DOCUMENT OR ANY SOFTWARE OR ACCOMPANYING HARDWARE, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. To the extent permitted by applicable law, Cypress reserves the right to make changes to this document without further notice. Cypress does not assume any liability arising out of the application or use of any product or circuit described in this document. Any information provided in this document, including any sample design information or programming code, is provided only for reference purposes. It is the responsibility of the user of this document to properly design, program, and test the functionality and safety of any application made of this information and any resulting product. Cypress products are not designed, intended, or authorized for use as critical components in systems designed or intended for the operation of weapons, weapons systems, nuclear installations, life-support devices or systems, other medical devices or systems (including resuscitation equipment and surgical implants), pollution control or hazardous substances management, or other uses where the failure of the device or system could cause personal injury, death, or property damage ("Unintended Uses"). A critical component is any component of a device or system whose failure to perform can be reasonably expected to cause the failure of the device or system, or to affect its safety or effectiveness. Cypress is not liable, in whole or in part, and you shall and hereby do release Cypress from any claim, damage, or other liability arising from or related to all Unintended Uses of Cypress products. You shall indemnify and hold Cypress harmless from and against all claims, costs, damages, and other liabilities, including claims for personal injury or death, arising from or related to any Unintended Uses of Cypress products.

Cypress, the Cypress logo, Spansion, the Spansion logo, and combinations thereof, WICED, PSoC, CapSense, EZ-USB, F-RAM, and Traveo are trademarks or registered trademarks of Cypress in the United States and other countries. For a more complete list of Cypress trademarks, visit [cypress.com](http://cypress.com). Other names and brands may be claimed as property of their respective owners.

## X-ON Electronics

Largest Supplier of Electrical and Electronic Components

*Click to view similar products for [NAND Flash](#) category:*

*Click to view products by [Cypress](#) manufacturer:*

Other Similar products are found below :

[TC58BVG1S3HBIAI6](#) [EAN62827101](#) [TC58NVG1S3HBIAI4](#) [MT29F256G08AUCABH3-10ITZ:A](#) [MT29F4G08ABADAWP-ITX:D](#)  
[MT29F128G08AKCABH2-10ITZ:A](#) [MT29F64G08AECABH1-10ITZ:A](#) [TH58NVG2S3HBIAI4](#) [S99ML04G10019](#) [W29N02KVSIAF](#)  
[MT29F4G01ABAFDWB-IT:F](#) [MT29F8G01ADAFD12-IT:F TR](#) [W25N01JWSFIT](#) [AS5F34G04SND-08LIN](#) [AS5F14G04SND-10LIN](#)  
[AS5F32G04SND-08LIN](#) [AS5F12G04SND-10LIN](#) [AS5F31G04SND-08LIN](#) [AS5F18G04SND-10LIN](#) [W25N02JWTBIF](#)  
[S34ML08G301TFI000](#) [W25N02JWZEIC](#) [W25N02JWSFIF](#) [AS5F38G04SND-08LIN](#) [AT45DQ161-SSHFB-B](#) [SST26WF080B-104I/MF](#)  
[SST26WF016B-104I/MF](#) [SST26VF064B-104I/SO](#) [SST25VF512A-33-4I-SAE](#) [MT29F128G08AJAAAWP-ITZ:A](#)  
[MT29F32G08CBADAWP:D](#) [SST26WF040B-104I/SN](#) [SST25WF040B-40I/SN](#) [SST25VF512A-33-4C-SAE](#) [SST25VF040B-50-4I-S2AE](#)  
[SST25VF010A-33-4I-SAE](#) [SST25LF020A-33-4I-SAE](#) [SST25WF080B-40I/SN](#) [AT17F16-30CU](#) [IS34ML01G084-TLI](#)  
[S34ML08G101BHA000](#) [S34ML16G202BHI000](#) [TH58NYG3S0HBIAI4](#) [S34MS16G202BHI000](#) [IS37SML01G1-LLI](#) [IS34MW01G164-BLI](#)  
[IS34ML01G084-BLI](#) [IS34ML01G081-BLI](#) [S34ML01G100TFB000](#) [S34ML01G200TFI900](#)